

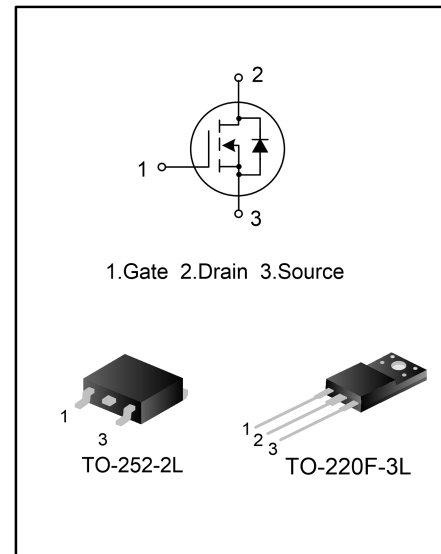
## 7A, 600V DP MOS POWER TRANSISTOR

### DESCRIPTION

SVS7N60D(F)D2 is an N-channel enhancement mode high voltage power MOSFETs produced using Silan's DP MOS technology. It achieves low conduction loss and switching losses. It leads the design engineers to their power converters with high efficiency, high power density, and superior thermal behavior. Furthermore, it's universal applicable, for example, it is suitable for hard and soft switching topologies.

### FEATURES

- ◆ 7A,600V,  $R_{DS(on)(typ.)}=0.48\Omega@V_{GS}=10V$
- ◆ New revolutionary high voltage technology
- ◆ Ultra low gate charge
- ◆ Enhanced avalanche capability
- ◆ Extreme dv/dt rated
- ◆ High peak current capability



### ORDERING INFORMATION

Part No.	Package	Marking	Hazardous substance control	Packing
SVS7N60DD2	TO-252-2L	SVS7N60DD2	Halogen free	Tube
SVS7N60DD2TR	TO-252-2L	SVS7N60DD2	Halogen free	Tape & Reel
SVS7N60FD2	TO-220F-3L	SVS7N60FD2	Halogen free	Tube

### ABSOLUTE MAXIMUM RATINGS (Unless otherwise noted, $T_C=25^\circ\text{C}$ )

Characteristics	Symbol	Ratings		Unit
		SVS7N60FD2	SVS7N60DD2	
Drain-Source Voltage	$V_{DS}$	600		V
Gate-Source Voltage	$V_{GS}$	$\pm 30$		V
Drain Current	$I_D$	$T_C=25^\circ\text{C}$	7.0	A
		$T_C=100^\circ\text{C}$	4.4	
Drain Current Pulsed	$I_{DM}$	28		A
Power Dissipation ( $T_C=25^\circ\text{C}$ ) - Derate above $25^\circ\text{C}$	$P_D$	30	60	W
		0.24	0.48	W/ $^\circ\text{C}$
Single Pulsed Avalanche Energy (Note 1)	$E_{AS}$	255		mJ
Operation Junction Temperature Range	$T_J$	-55~+150		$^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	-55~+150		$^\circ\text{C}$

## THERMAL CHARACTERISTICS

Characteristics	Symbol	Ratings		Unit
		SVS7N60FD2	SVS7N60DD2	
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	4.17	2.08	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	62.0	°C/W

## ELECTRICAL CHARACTERISTICS (Unless otherwise noted, $T_C=25^\circ\text{C}$ )

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain -Source Breakdown Voltage	$B_{VDSS}$	$V_{GS}=0V, I_D=250\mu A$	600	--	--	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=600V, V_{GS}=0V$	--	--	1.0	$\mu A$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 30V, V_{DS}=0V$	--	--	$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	2.0	--	4.0	V
Static Drain- Source on State Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=3.5A$	--	0.48	0.58	$\Omega$
Input Capacitance	$C_{iss}$	$V_{DS}=100V, V_{GS}=0V,$ $f=1.0\text{MHZ}$	--	450	--	pF
Output Capacitance	$C_{oss}$		--	29	--	
Reverse Transfer Capacitance	$C_{rss}$		--	6.7	--	
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=300V, I_D=7.0A,$ $V_{GS}=10V, R_G=24\Omega$	--	10.3	--	ns
Turn-on Rise Time	$t_r$		--	32.6	--	
Turn-off Delay Time	$t_{d(off)}$		--	72.2	--	
Turn-off Fall Time	$t_f$		(Note 2,3)	--	28.9	
Total Gate Charge	$Q_g$	$V_{DS}=480V, I_D=7.0A,$ $V_{GS}=10V$	--	22.9	--	nC
Gate-Source Charge	$Q_{gs}$		--	3.54	--	
Gate-Drain Charge	$Q_{gd}$		(Note 2,3)	--	13.2	

## SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	$I_S$	Integral Reverse P-N Junction Diode in the MOSFET	--	--	7.0	A
Pulsed Source Current	$I_{SM}$		--	--	28.0	
Diode Forward Voltage	$V_{SD}$	$I_S=7.0A, V_{GS}=0V$	--	--	1.4	V
Reverse Recovery Time	$T_{rr}$	$I_S=7.0A, V_{GS}=0V,$ $dl_f/dt=100A/\mu s$	--	430	--	ns
Reverse Recovery Charge	$Q_{rr}$		--	3.2	--	$\mu C$

### Notes:

1.  $L=79\text{mH}, I_{AS}=2.4A, V_{DD}=100V, R_G=25\Omega$ , starting temperature  $T_J=25^\circ\text{C}$ ;
2. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$ ;
3. Essentially independent of operating temperature.

**TYPICAL CHARACTERISTICS**

Figure 1. On-Region Characteristics

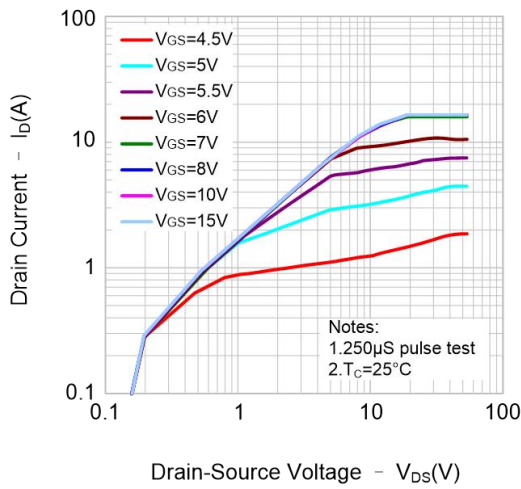


Figure 2. Transfer Characteristics

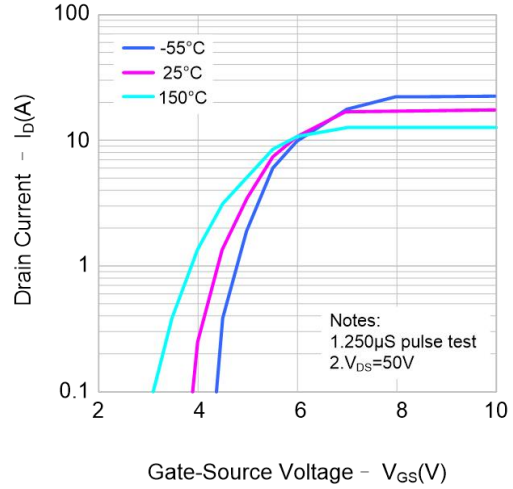


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

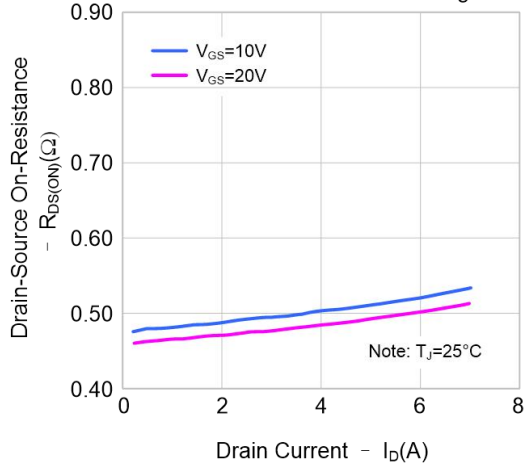


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

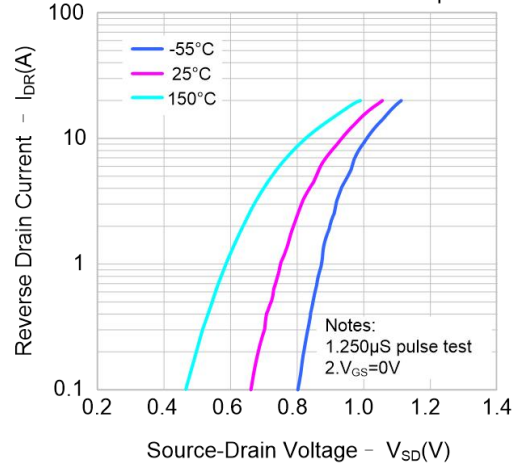


Figure 5. Capacitance Characteristics

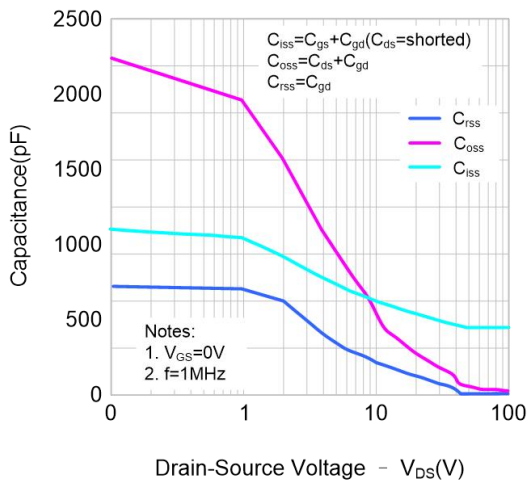
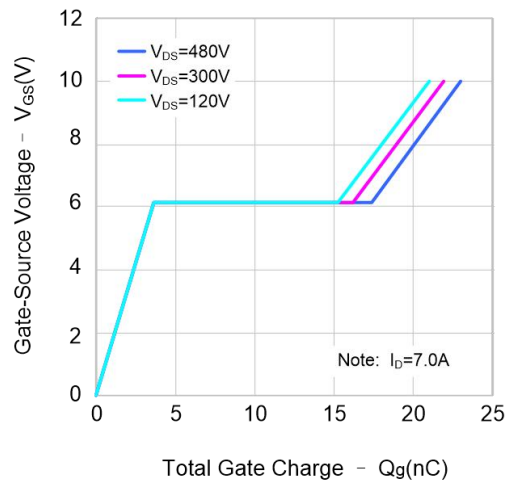


Figure 6. Gate Charge Characteristics



**TYPICAL CHARACTERISTICS (continued)**

Figure 7. Breakdown Voltage Variation vs. Temperature

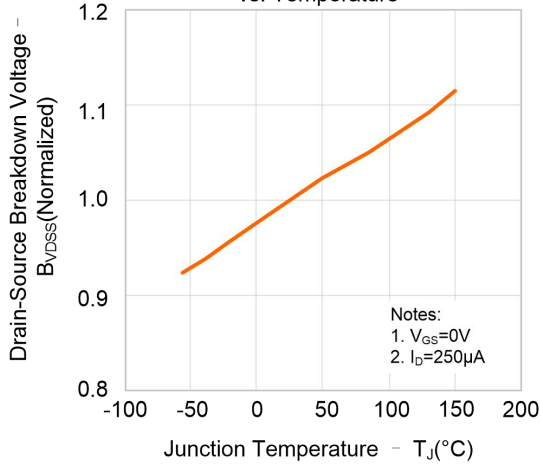


Figure 8. On-resistance Variation vs. Temperature

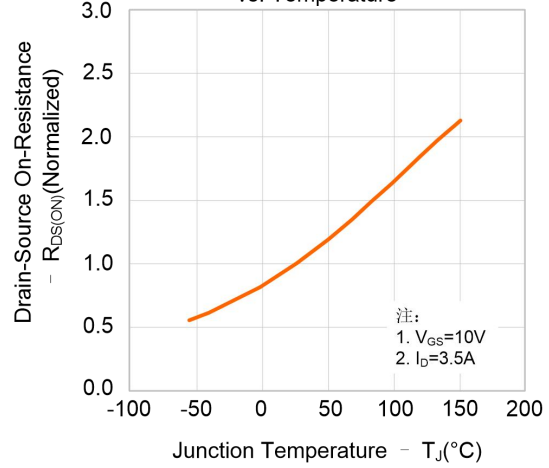


Figure 9-1. Max. Safe Operating Area (SVS7N60DD2)

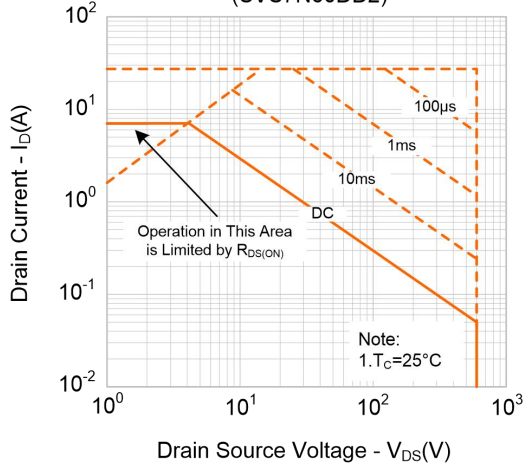
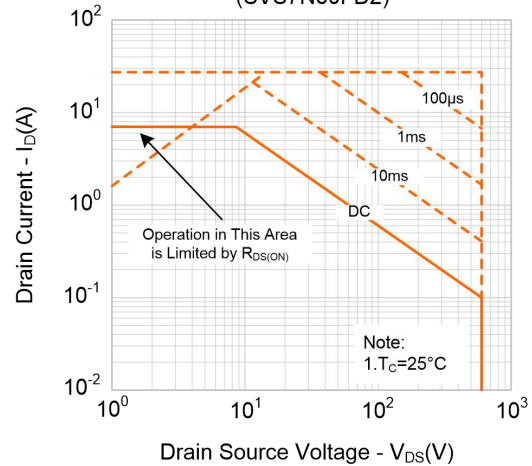
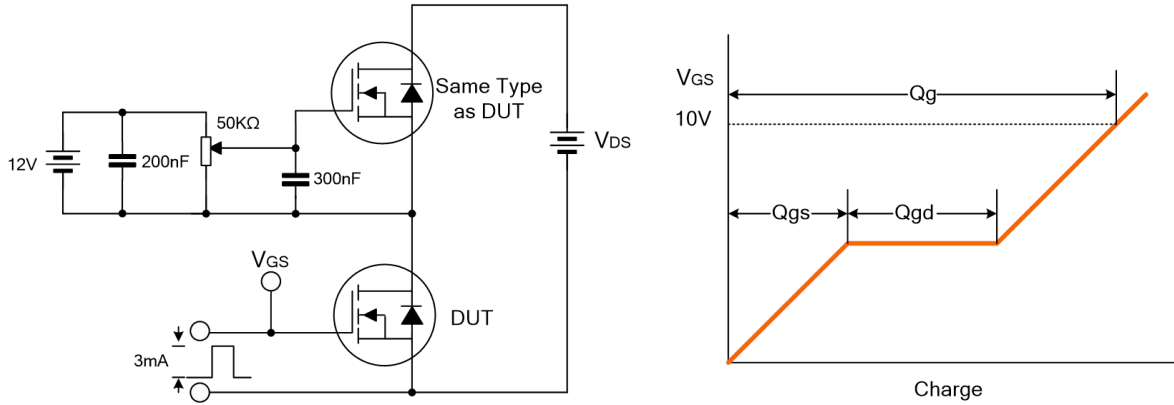


Figure 9-2. Max. Safe Operating Area (SVS7N60FD2)

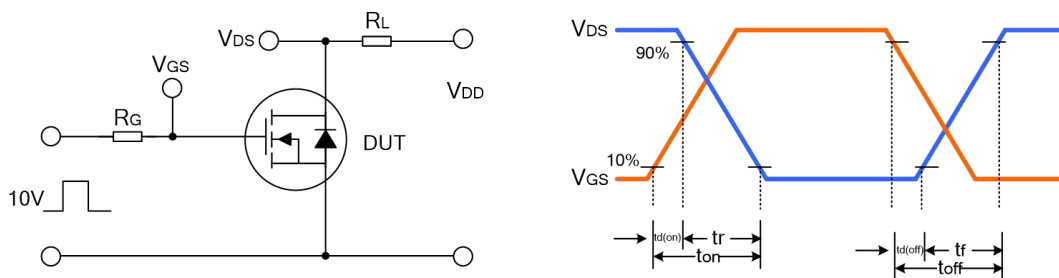


**TYPICAL TEST CIRCUIT**

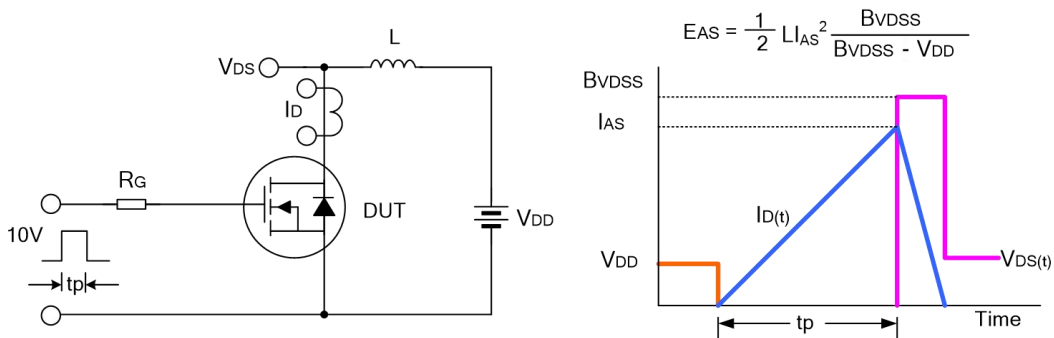
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform



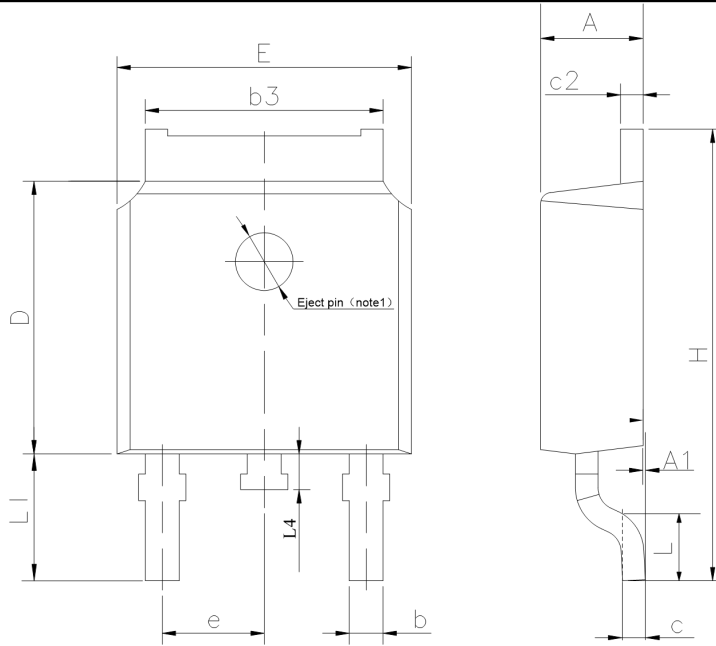
Unclamped Inductive Switching Test Circuit & Waveform



PACKAGE OUTLINE

TO-252-2L

UNIT: mm

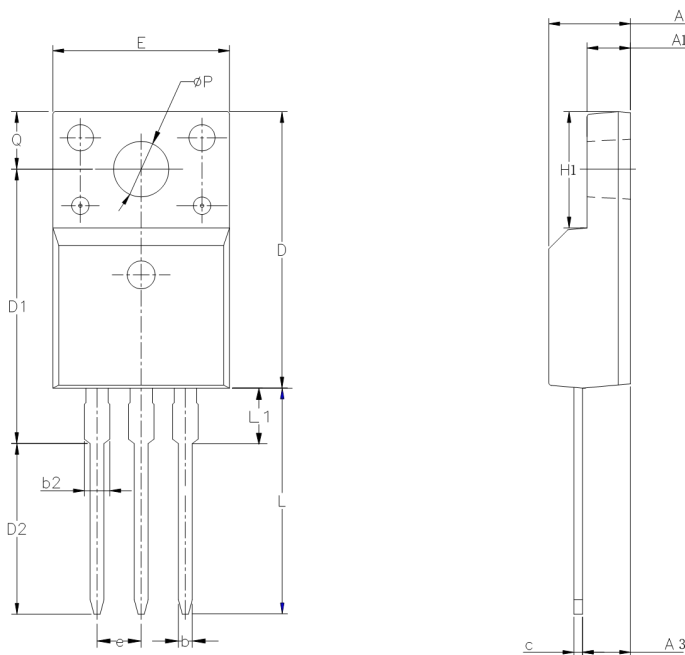


SYMBOL	MIN	NOM	MAX
A	2.10	2.30	2.50
A1	0	---	0.127
b	0.66	0.76	0.89
b3	5.10	5.33	5.46
c	0.45	---	0.65
c2	0.45	---	0.65
D	5.80	6.10	6.40
E	6.30	6.60	6.90
e	2.30TYP		
H	9.60	10.10	10.60
L	1.40	1.50	1.70
L1	2.90REF		
L4	0.60	0.80	1.00

NOTE 1 : There are two conditions for this position:has an eject pin or has no eject pin.

TO-220F-3L

UNIT: mm



SYMBOL	MIN	NOM	MAX
A	4.42	4.70	5.02
A1	2.30	2.54	2.80
A3	2.50	2.76	3.10
b	0.70	0.80	0.90
b2	—	—	1.47
c	0.35	0.50	0.65
D	15.25	15.87	16.25
D1	15.30	15.75	16.30
D2	9.30	9.80	10.30
E	9.73	10.16	10.36
e	2.54BCS		
H1	6.40	6.68	7.00
L	12.48	12.98	13.48
L1	/	/	3.50
ØP	3.00	3.18	3.40
Q	3.05	3.30	3.55

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Rev.:	1.0	Author:	Yin Zi
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Revision History:

1. First release
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